N-Channel Power MOSFET 500 V, 0.69 Ω

Features

- Low ON Resistance
- Low Gate Charge
- 100% Avalanche Tested
- These Devices are Pb-Free and are RoHS Compliant

ABSOLUTE MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Rating	Symbol	NDF08N50Z	NDP08N50Z	Unit
Drain-to-Source Voltage	V _{DSS}	500		V
Continuous Drain Current $R_{\theta JC}$	I _D	7.5 (Note 1) 7.5		Α
Continuous Drain Current R _{θJC} T _A = 100°C	I _D	4.7 (Note 1)	4.7	Α
Pulsed Drain Current, V _{GS} @ 10 V	I _{DM}	30 (Note 1) 30		Α
Power Dissipation	P_{D}	31	125	W
Gate-to-Source Voltage	V _{GS}	3	0	V
Single Pulse Avalanche Energy, I _D = 7.5 A	E _{AS}	190		mJ
ESD (HBM) (JESD 22-A114)	V _{esd}	3500		V
RMS Isolation Voltage (t = 0.3 sec., R.H. \leq 30%, T _A = 25°C) (Figure 14)	V _{ISO}	4500		V
Peak Diode Recovery	dv/dt	4.5		V/ns
Continuous Source Current (Body Diode)	I _S	7.5		Α
Maximum Temperature for Soldering Leads	TL	260		°C
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to 150		°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

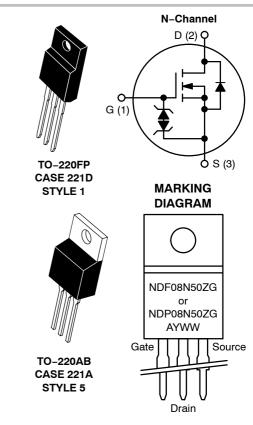
- 1. Limited by maximum junction temperature
- 2. $I_{SD} = 7.5 \text{ A}$, $di/dt \le 100 \text{ A/}\mu\text{s}$, $V_{DD} \le BV_{DSS}$, $T_J = +150^{\circ}\text{C}$



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V _{DSS}	R _{DS(ON)} (TYP) @ 3.6 A		
500 V	0.69 Ω		



A = Location Code

Y = Year WW = Work Week

G = Pb-Free Package

ORDERING INFORMATION

Device	Package	Shipping
NDF08N50ZG	TO-220FP	50 Units/Rail
NDP08N50ZG	TO-220AB	In Development

THERMAL RESISTANCE

Parameter		NDF08N50Z	NDP08N50Z	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	4.0	1.0	°C/W
Junction-to-Ambient Steady State (Note 3)	$R_{\theta JA}$	50	50	

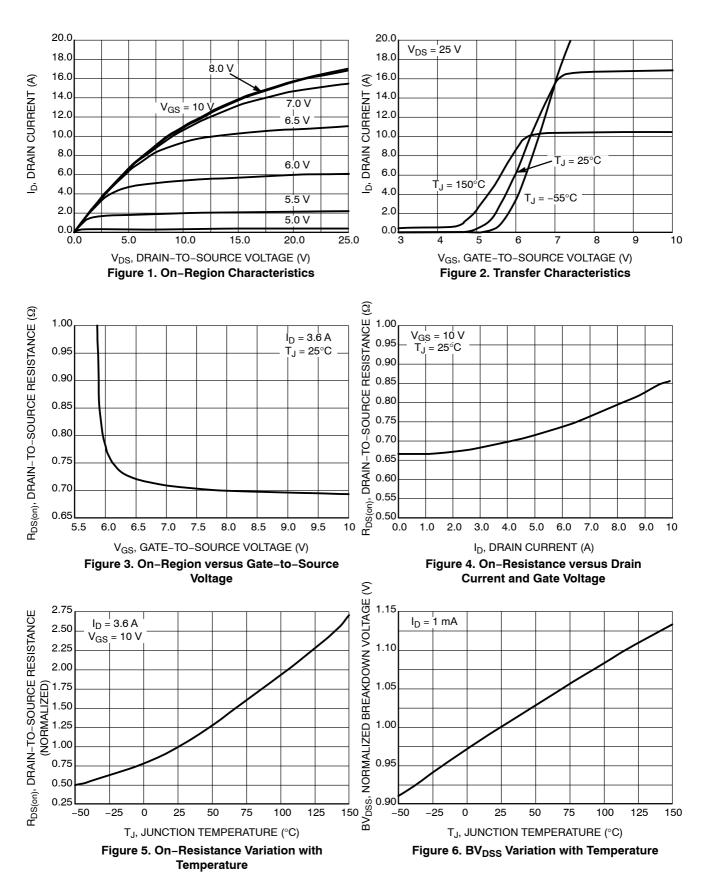
^{3.} Insertion mounted

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Characteristic	Test Conditions		Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS					-		-
Drain-to-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 1 mA		BV _{DSS}	500			V
Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D = 1 mA		$\Delta BV_{DSS}/ \Delta T_{J}$		0.6		V/°C
Drain-to-Source Leakage Current	V 500 V V 0 V	25°C	I _{DSS}			1	μΑ
	$V_{DS} = 500 \text{ V}, V_{GS} = 0 \text{ V}$	150°C				50	1
Gate-to-Source Forward Leakage	V _{GS} = ±20 V		I _{GSS}			±10	μΑ
ON CHARACTERISTICS (Note 4)							
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 3.6 \text{ A}$	A	R _{DS(on)}		0.69	0.85	Ω
Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu$	A	V _{GS(th)}	3.0		4.5	V
Forward Transconductance	V _{DS} = 15 V, I _D = 3.75 A		9FS		6.0		S
YNAMIC CHARACTERISTICS							
Input Capacitance		_	C _{iss}		912		pF
Output Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz		C _{oss}		120		-
Reverse Transfer Capacitance			C _{rss}		27		
Total Gate Charge	V _{DD} = 250 V, I _D = 7.5 A,		Q_g		31		nC
Gate-to-Source Charge			Q _{gs}		6.2		1
Gate-to-Drain ("Miller") Charge	$V_{GS} = 10 \text{ V}$		Q _{gd}		17		1
Plateau Voltage			V _{GP}		6.3		V
Gate Resistance			R _g		3.0		Ω
ESISTIVE SWITCHING CHARACTERI	STICS				-	•	
Turn-On Delay Time			t _{d(on)}		13		ns
Rise Time	V_{DD} = 250 V, I_D = 7.5 A, V_{GS} = 10 V, R_G = 5 Ω		t _r		23		
Turn-Off Delay Time			t _{d(off)}		31		
Fall Time			t _f		29		
OURCE-DRAIN DIODE CHARACTER	ISTICS (T _C = 25°C unless other	erwise note	ed)				
Diode Forward Voltage	I _S = 7.5 A, V _{GS} = 0 V		V _{SD}			1.6	V
Reverse Recovery Time	$V_{GS} = 0 \text{ V}, V_{DD} = 30 \text{ V}$ $I_{S} = 7.5 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		t _{rr}		295		ns
Reverse Recovery Charge			Q _{rr}		1.85		μC

^{4.} Pulse Width \leq 380 $\mu s,$ Duty Cycle \leq 2%.

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

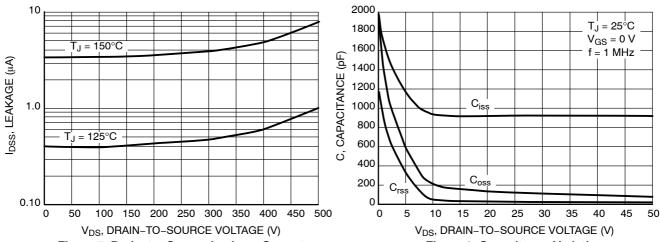


Figure 7. Drain-to-Source Leakage Current versus Voltage

Figure 8. Capacitance Variation

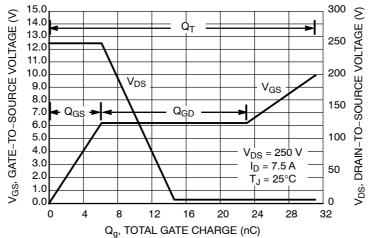


Figure 9. Gate-to-Source Voltage and Drain-to-Source Voltage versus Total Charge

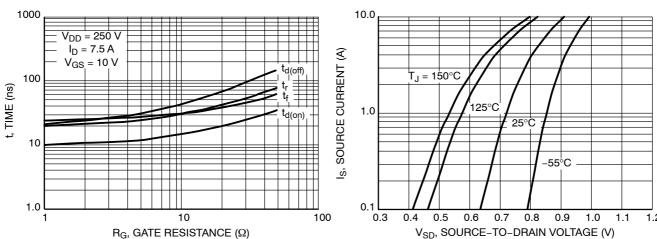


Figure 10. Resistive Switching Time Variation versus Gate Resistance

Figure 11. Diode Forward Voltage versus Current

TYPICAL CHARACTERISTICS

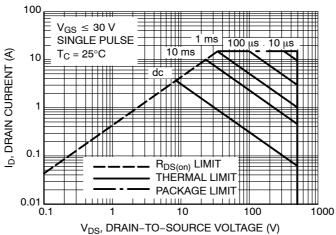


Figure 12. Maximum Rated Forward Biased Safe Operating Area NDF08N50Z

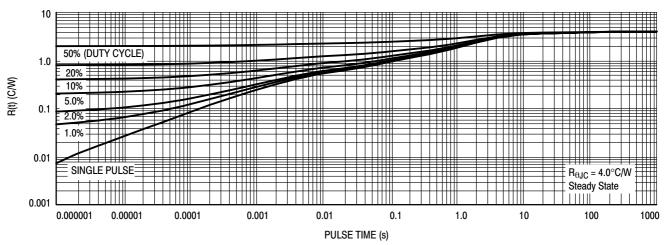


Figure 13. Thermal Impedance (Junction-to-Case) for NDF08N50Z

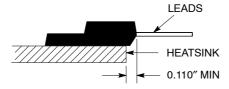


Figure 14. Isolation Test Diagram

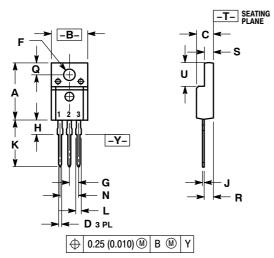
Measurement made between leads and heatsink with all leads shorted together.

*For additional mounting information, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

TO-220 FULLPAK

CASE 221D-03 ISSUE K



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
 V14 FM 1992
- Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH
- 3. 221D-01 THRU 221D-02 OBSOLETE, NEW STANDARD 221D-03.

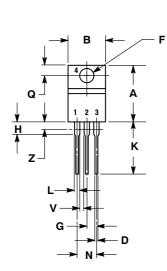
	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.617	0.635	15.67	16.12	
В	0.392	0.419	9.96	10.63	
С	0.177	0.193	4.50	4.90	
D	0.024	0.039	0.60	1.00	
F	0.116	0.129	2.95	3.28	
G	0.100 BSC		2.54 BSC		
Н	0.118	0.135	3.00	3.43	
J	0.018	0.025	0.45	0.63	
K	0.503	0.541	12.78	13.73	
L	0.048	0.058	1.23	1.47	
N	0.200 BSC		5.08 BSC		
Q	0.122	0.138	3.10	3.50	
R	0.099	0.117	2.51	2.96	
S	0.092	0.113	2.34	2.87	
U	0.239	0.271	6.06	6.88	

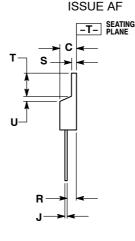
STYLE 1:

PIN 1. GATE

- 2. DRAIN
- 3. SOURCE

TO-220 CASE 221A-09





NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH.
 DIMENSION Z DEFINES A ZONE WHERE ALL
- DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INCHES		MILLIMETERS	
DIM	MIN	MAX	MIN	MAX
Α	0.570	0.620	14.48	15.75
В	0.380	0.405	9.66	10.28
С	0.160	0.190	4.07	4.82
D	0.025	0.035	0.64	0.88
F	0.142	0.161	3.61	4.09
G	0.095	0.105	2.42	2.66
Н	0.110	0.155	2.80	3.93
J	0.014	0.025	0.36	0.64
K	0.500	0.562	12.70	14.27
L	0.045	0.060	1.15	1.52
N	0.190	0.210	4.83	5.33
Q	0.100	0.120	2.54	3.04
R	0.080	0.110	2.04	2.79
S	0.045	0.055	1.15	1.39
T	0.235	0.255	5.97	6.47
U	0.000	0.050	0.00	1.27
٧	0.045		1.15	
Z		0.080		2.04

STYLE 5:

PIN 1. GATE

- 2. DRAIN
- 3. SOURCE 4. DRAIN

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